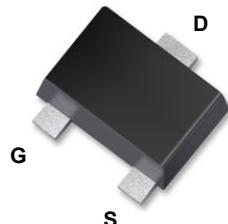
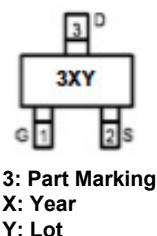


Main Product Characteristics

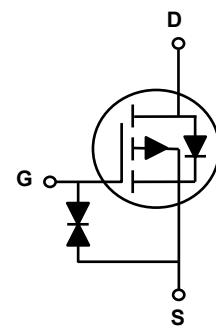
V_{DSS}	- 20V
$R_{DS(on)}$	440m Ω (typ.)
I_D	- 400mA



SOT-723



Marking and Pin Assignment



Schematic Diagram

Features and Benefits

- Advanced trench MOSFET process technology
- Ideal for PWM, load switching and general power management
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature
- Main applications: notebooks, load switching, battery protection, hand-held instruments.



Description

The SSF2319GE utilizes the latest processing techniques to achieve high cell density, low on-resistance and high repetitive avalanche rating. These features make this device extremely efficient and reliable for use in battery protection, power switching and a wide variety of other applications.

Absolute Max Ratings ($T_C=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	-20	V
Gate-Source Voltage	V_{GS}	± 8	V
Drain Current-Continuous($T_C=25^\circ\text{C}$)	I_D	-400	mA
Drain Current-Continuous($T_C=100^\circ\text{C}$)	I_D	-250	mA
Drain Current-Pulsed (Note 1)	I_{DM}	-1.6	A
Maximum Power Dissipation	P_D	275	mW
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To +150	°C

Thermal Resistance

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	450	°C/W
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Electrical Characteristics (T_A=25°C unless otherwise specified)

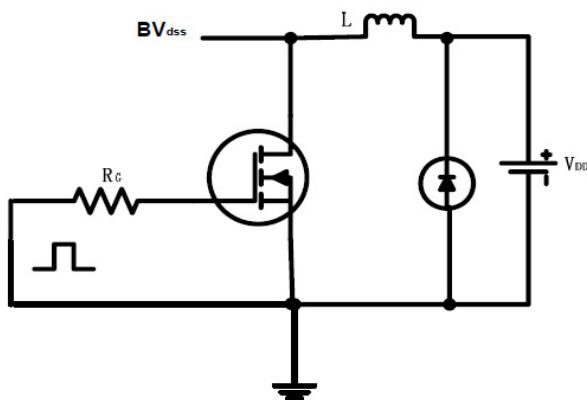
Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	-20			V
BV _{DSS} Temperature Coefficient	△BV _{DSS} /△T _J	Reference to 25°C, I _D = -1mA		-0.01		V/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -20V, V _{GS} =0V			-1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±6V, V _{DS} =0V			±20	uA
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D = -250μA	-0.3	-0.6	-1.0	V
V _{GS(th)} Temperature Coefficient	△V _{GS(th)}	V _{DS} =V _{GS} , I _D = -250μA		3		mV/°C
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} = -4.5V, I _D = -0.3A		440	600	mΩ
		V _{GS} = -2.5V, I _D = -0.2A		610	850	
		V _{GS} = -1.8V, I _D = -0.1A		810	1200	
		V _{GS} = -1.5V, I _D = -0.1A		1020	1600	
		V _{GS} = -1.2V, I _D = -0.1A		1800	3000	
DYNAMIC CHARACTERISTICS (Note4)						
Input Capacitance	C _{iss}	V _{DS} = -10V, V _{GS} =0V, F=1.0MHz		40	78	PF
Output Capacitance	C _{oss}			15	30	PF
Reverse Transfer Capacitance	C _{rss}			6.5	13	PF
SWITCHING CHARACTERISTICS (Note 4)						
Turn-on Delay Time	t _{d(on)}	V _{DD} = -10V, I _D = 0.2A V _{GS} = -4.5V, R _{GEN} =10Ω		8	16	nS
Turn-on Rise Time	t _r			5.2	10	nS
Turn-Off Delay Time	t _{d(off)}			30	60	nS
Turn-Off Fall Time	t _f			18	36	nS
Total Gate Charge	Q _g	V _{DS} = -10V, I _D = -0.2A, V _{GS} = -4.5V		1	2	nC
Gate-Source Charge	Q _{gs}			0.28	0.5	nC
Gate-Drain Charge	Q _{gd}			0.18	0.4	nC
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V, I _S = -0.2A		-0.8	-1.0	V
Diode Forward Current (Note 2)	I _S	V _G =V _D =0V , Force Current			-400	mA

Note :

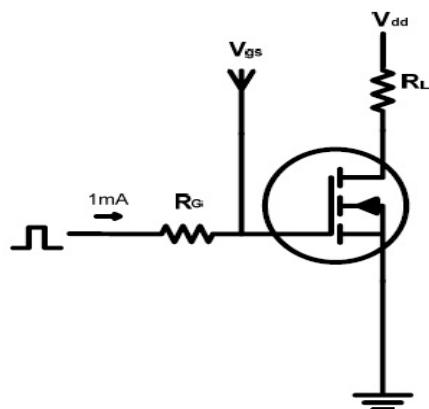
1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
3. Essentially independent of operating temperature.

Test Circuits and Waveforms

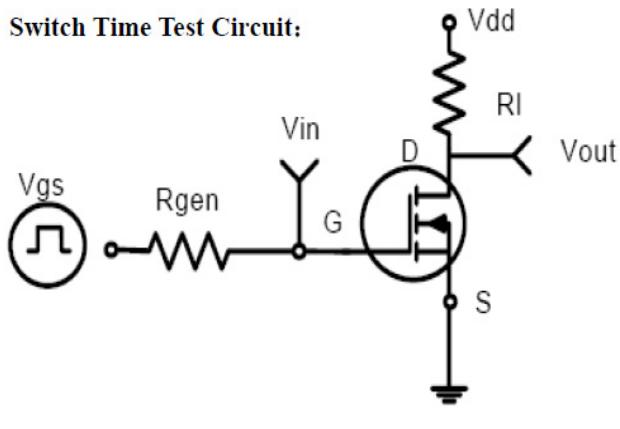
EAS test circuits:



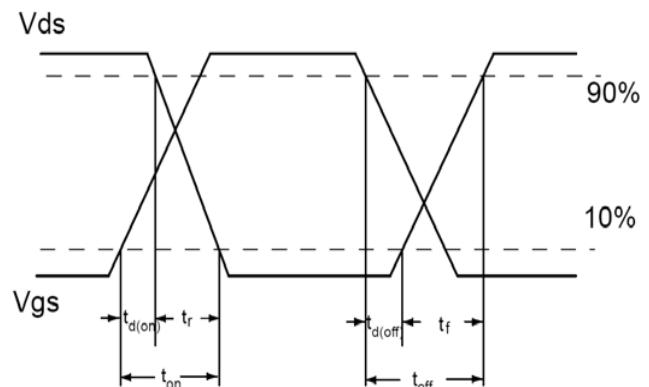
Gate charge test circuit:



Switch Time Test Circuit:



Switch Waveforms:



NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production testing.

Typical Electrical and Thermal Characteristics

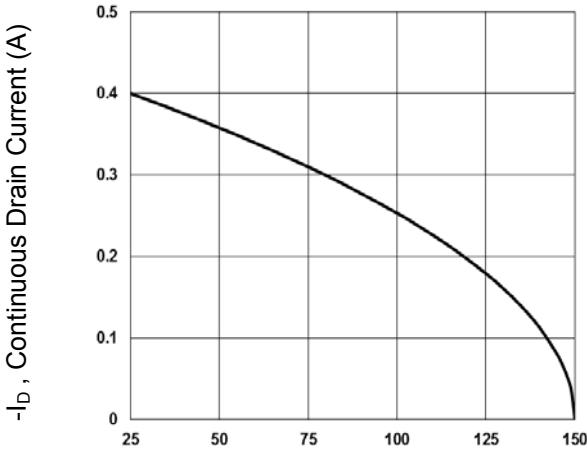


Figure 1. Drain Current vs. T_j

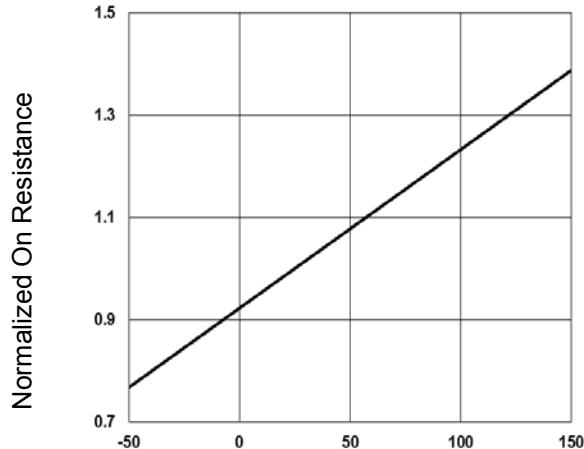


Figure 2. Normalized R_{DS(on)} vs. T_j

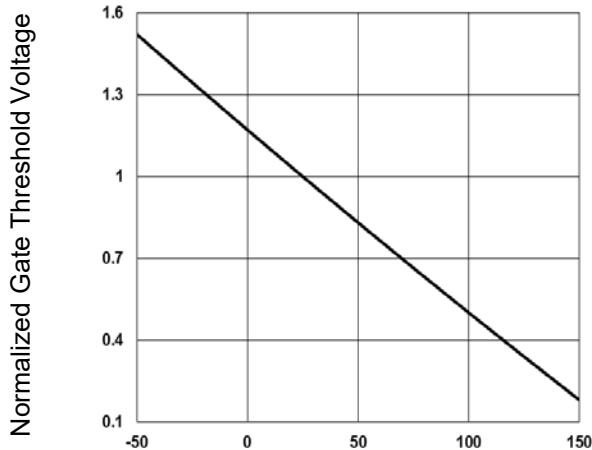


Figure 3. Normalized V_{th} vs. T_j

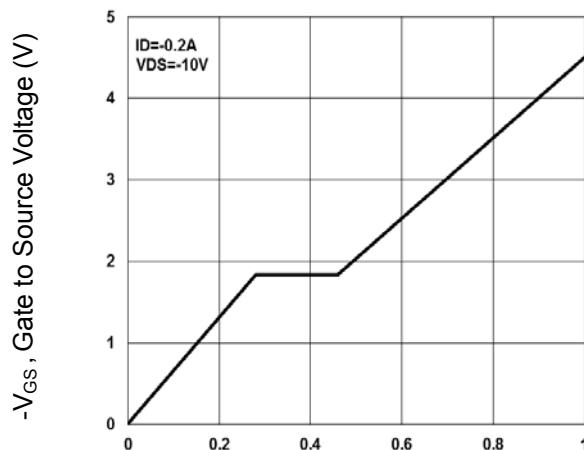


Figure 4. Gate Charge Waveform

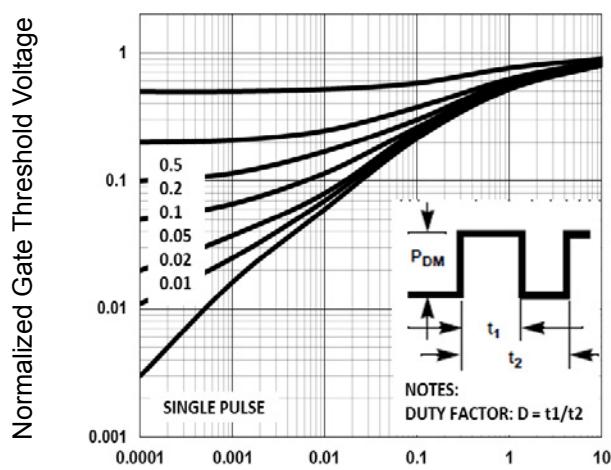


Figure 5. Normalized Transient Response

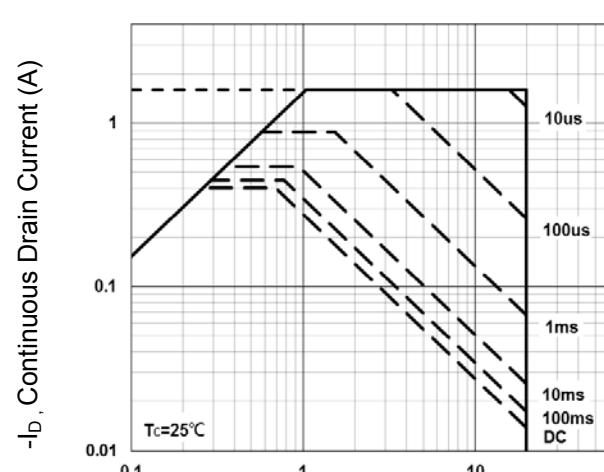
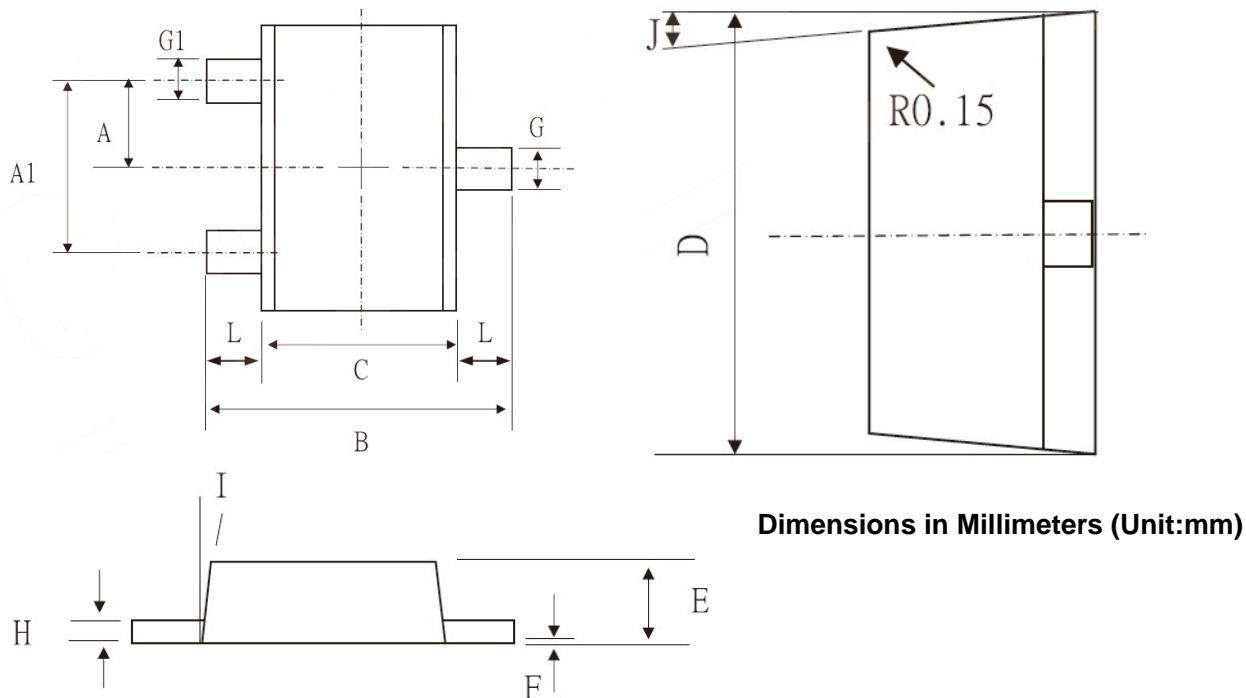


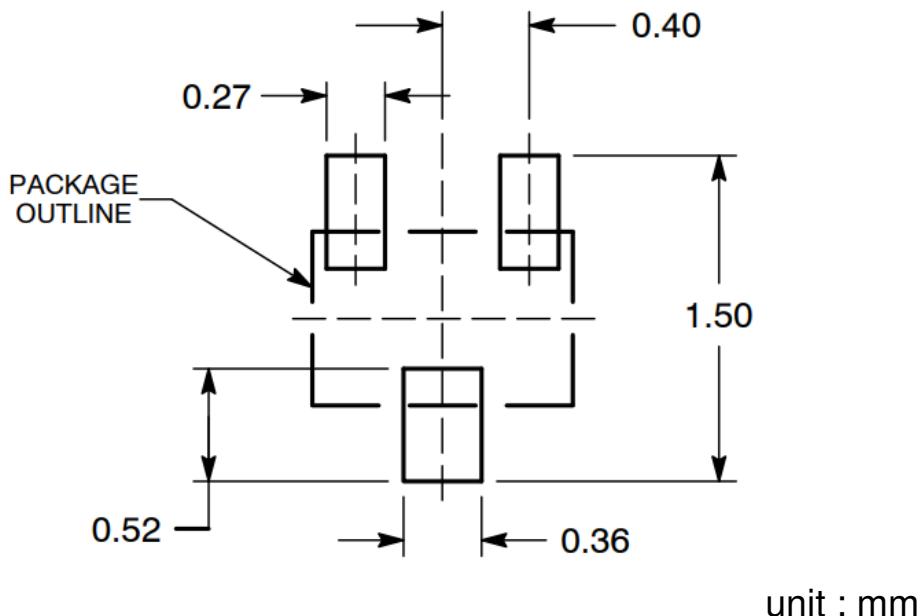
Figure 6. Safe Operation Area

Package Outline Dimensions (SOT-723)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	0.4BSC		0.016BSC	
A1	0.8BSC		0.031BSC	
B	1.250	1.150	0.049	0.045
C	0.850	0.750	0.033	0.030
D	1.250	1.150	0.049	0.045
E	0.390	0.370	0.015	0.015
F	0.050	0.000	0.002	0.000
G	0.270	0.220	0.011	0.009
G1	0.220	0.170	0.009	0.007
H	0.110	0.009	0.004	0.000
I	13°	9°	13°	9°
L	0.250	0.150	0.010	0.006
J	11°	7°	11°	7°

Recommended Pad Layout



unit : mm